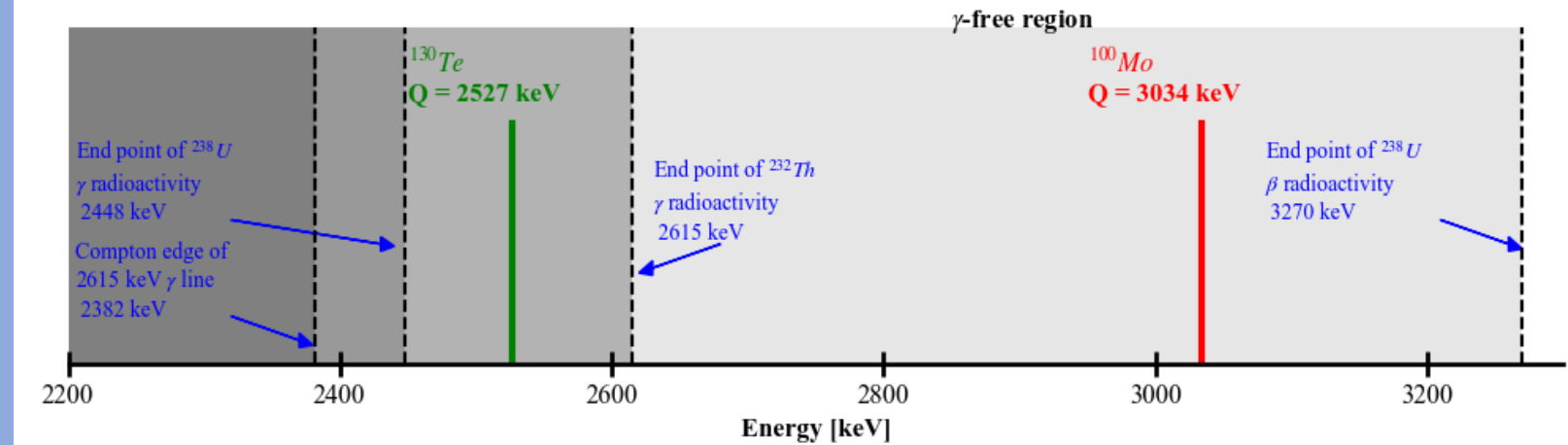




## 1. CROSS experiment

CROSS (Cryogenic Rare-event Observatory with Surface Sensitivity) is a project aiming at the development of a new bolometric technique to search for  $0\nu\beta\beta$  decay in  $^{100}\text{Mo}$  and  $^{130}\text{Te}$  nuclei.

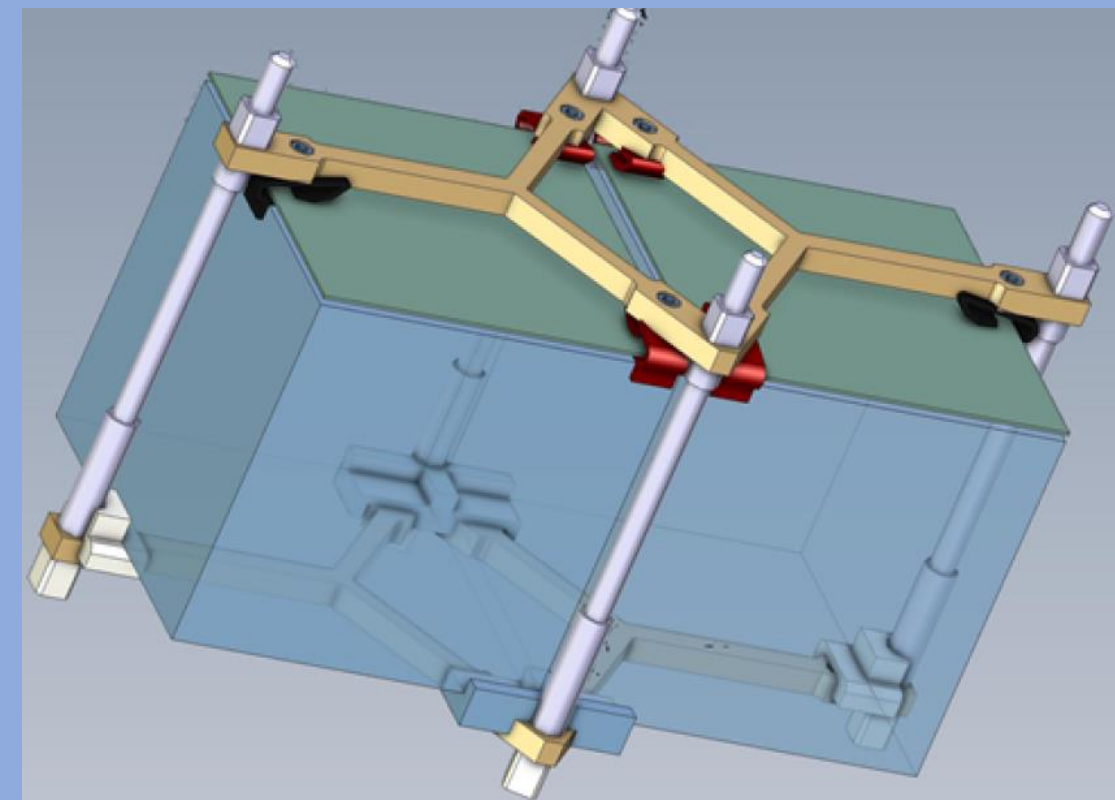


## 2. CROSS in a nutshell

- **Particle ID: Bulk / Surface**
  - R&D on metal-coated bolometers for discrimination between bulk and near surface interactions
- **Development of  $^{130}\text{TeO}_2$** 
  - protocol for the production of radiopure  $^{130}\text{Te}$ -enriched  $\text{TeO}_2$  bolometers
- **Production and use of  $\text{Li}_2^{100}\text{MoO}_4$  crystals**
- **Competitive experiment on the  $^{100}\text{Mo}$   $0\nu\beta\beta$**
- **Development of fully equipped underground facility (LSC, Canfranc, Spain) to test advanced bolometers**

## 4. CROSS detector structure [4]

- Cubic  $\text{Li}_2^{100}\text{MoO}_4$  (LMO) and  $^{130}\text{TeO}_2$  crystals ( $45 \times 45 \times 45 \text{ mm}^3$ ) and square Ge wafers ( $45 \times 45 \times 0.3 \text{ mm}^3$ )
  - Temperature sensors: neutron transmutation doped (NTD) Ge thermistors glued at crystals and Ge wafers with bi-component epoxy or UV-cured glue
  - Each crystal has a direct heat sinking through supporting elements made of polytetrafluoroethylene (PTFE) or other plastic material
  - Light detectors are kept with 3D-printed polylactic acid (PLA) clamps on the crystal
  - Cu-to-LMO mass ratio is minimized to 6% to decrease radioactivity from surface of close elements
- [4] arXiv:2405.18980 (2024)

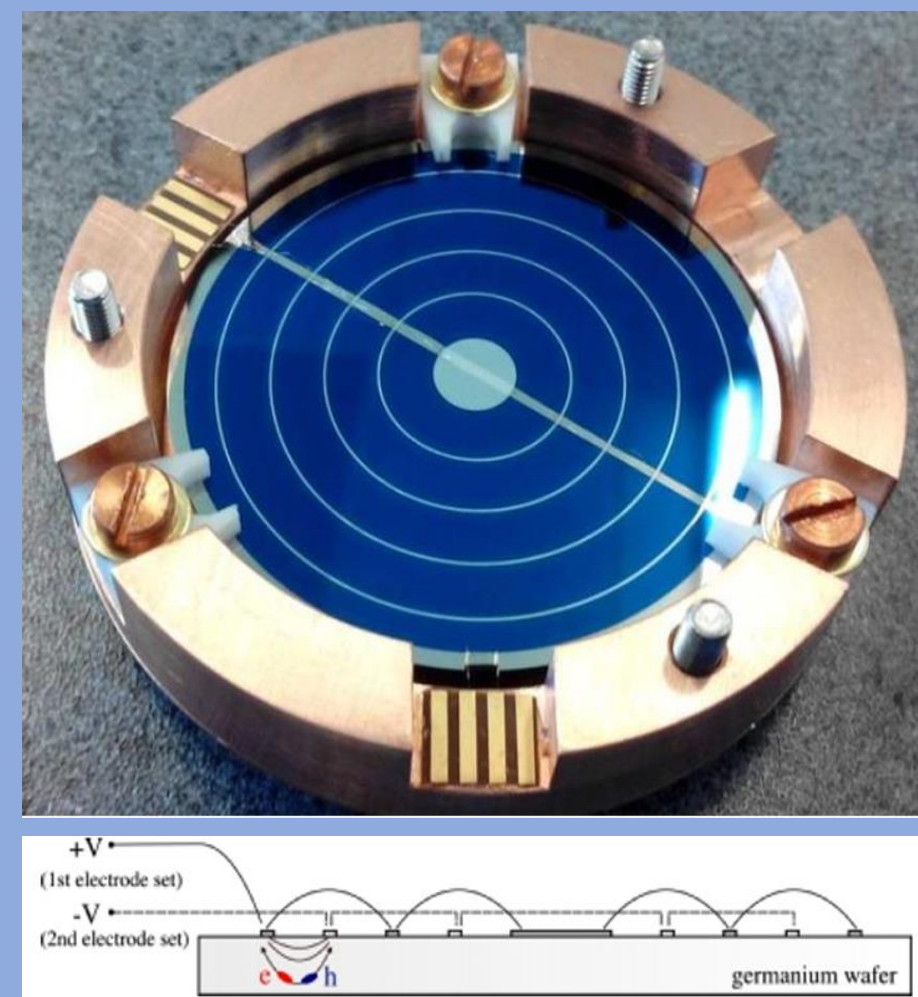


## 5. Neganov-Trofimov-Luke light detectors [5]

- Electronic grade purity Ge wafer with  $\text{SiO}_2$  anti-reflective coating (enhances light collection by  $\sim 30\%$ )
- Al electrodes are deposited and connected with Al bonding wires
- NTD is electrically connected to Au-coated copper pads on Kapton through gold bonding wire
- Amplification effect due to extra heat produced by charged carriers drifted by an electric field. Total heat:  $E_{\text{tot}} = E_0 \cdot G_{\text{NTL}}$ ;  $G_{\text{NTL}} \propto V_{\text{NTL}}$

### Essential NTL LD parameters

- $\sigma_{\text{baseline}}$  – baseline noise RMS after applying Gatti-Manfredi optimum filtering. When expressed in energy units represents also the signal-to-noise ratio for the LD. Important for  $\alpha/\beta(\gamma)$  discrimination and pile-up events rejection. Can be improved by a factor 10 thanks to the NTL effect
  - rise time – crucial for pile-up events rejection [6]. Can be kept below 0.5 ms at a proper operation point
- [5] NIMA 940 (2019) 320      [6] EPJC 83 (2023) 373      see poster N°474 by Antoine Armato



## 7. Recent results in Canfranc

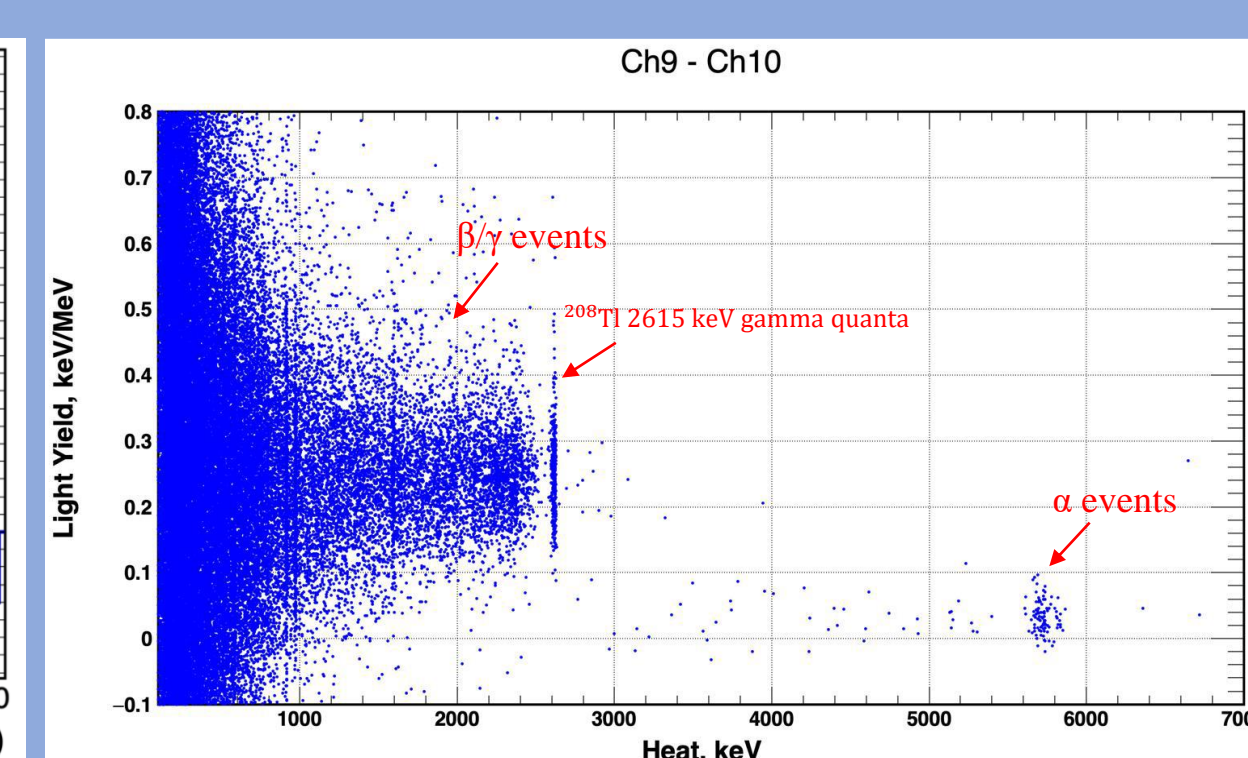
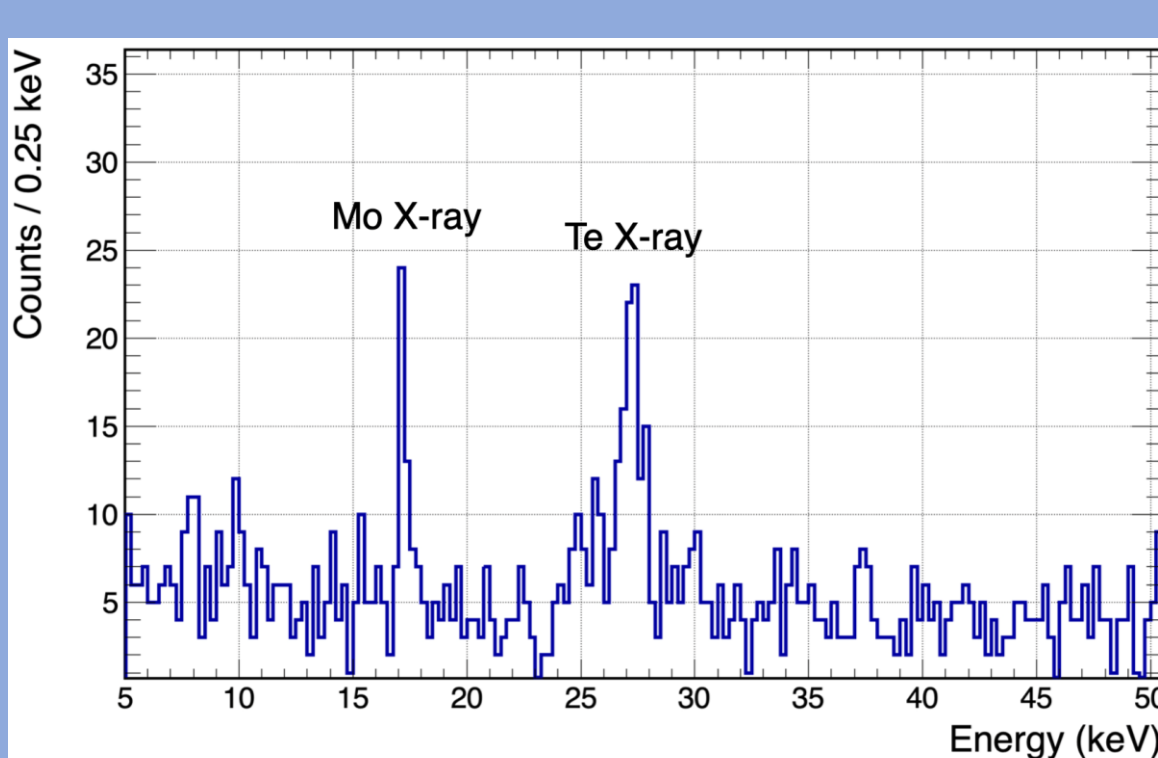
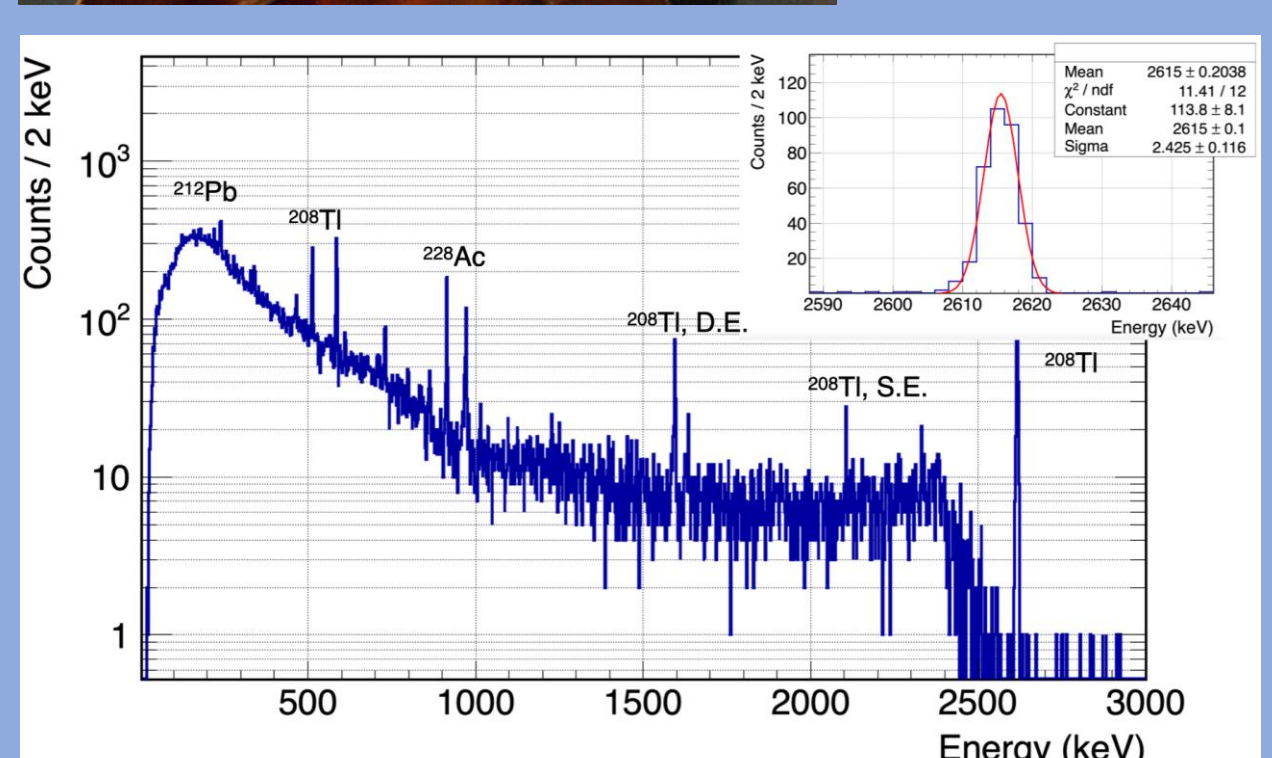
### 10-crystal structure:

- 6  $\text{Li}_2\text{MoO}_4$  crystals (2 reference high purity  $\text{Li}_2^{100}\text{MoO}_4$  crystals and 4 natural crystals from a US company that are under investigation)
- 2 bare  $^{130}\text{TeO}_2$  crystals
- 2  $^{130}\text{TeO}_2$  crystals with thin metallic coating (Al for one and Al-Pd for other)
- 10 NTL light detectors with circular electrodes geometry

Operation temperatures: 17–27 mK

### Measurements:

- Calibration measurements with  $^{232}\text{Th}$  source
- Background measurements
- Tests on pile-up rejection capability



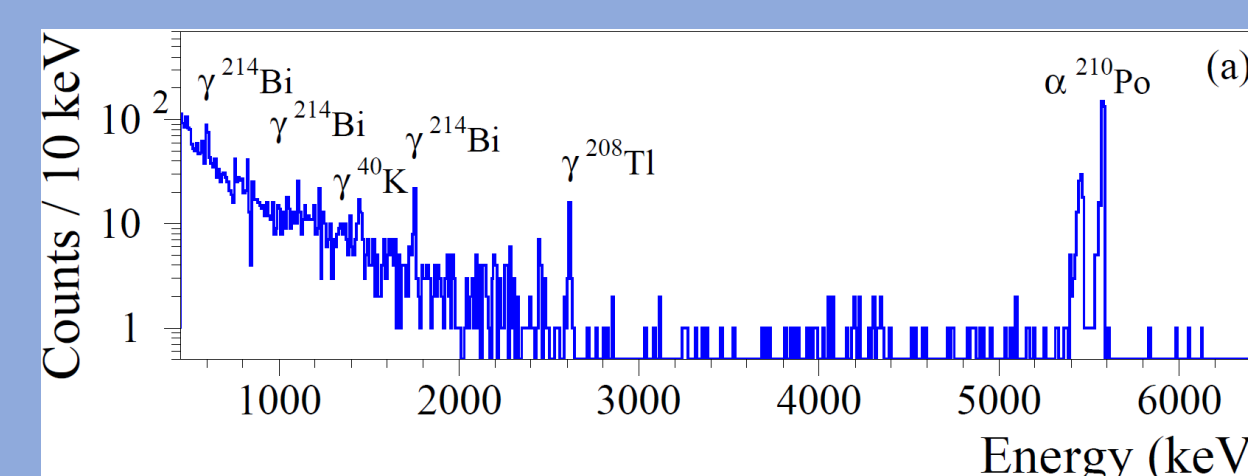
The calibration for one of the reference detectors  $\text{Li}_2^{100}\text{MoO}_4$ . Energy resolution @ 2615 keV  $^{208}\text{Tl}$  line is  $(5.7 \pm 0.3) \text{ keV}$

Mo and Te X-rays in the LD used for calibration

$\alpha/\beta(\gamma)$  events discrimination at 0 V bias

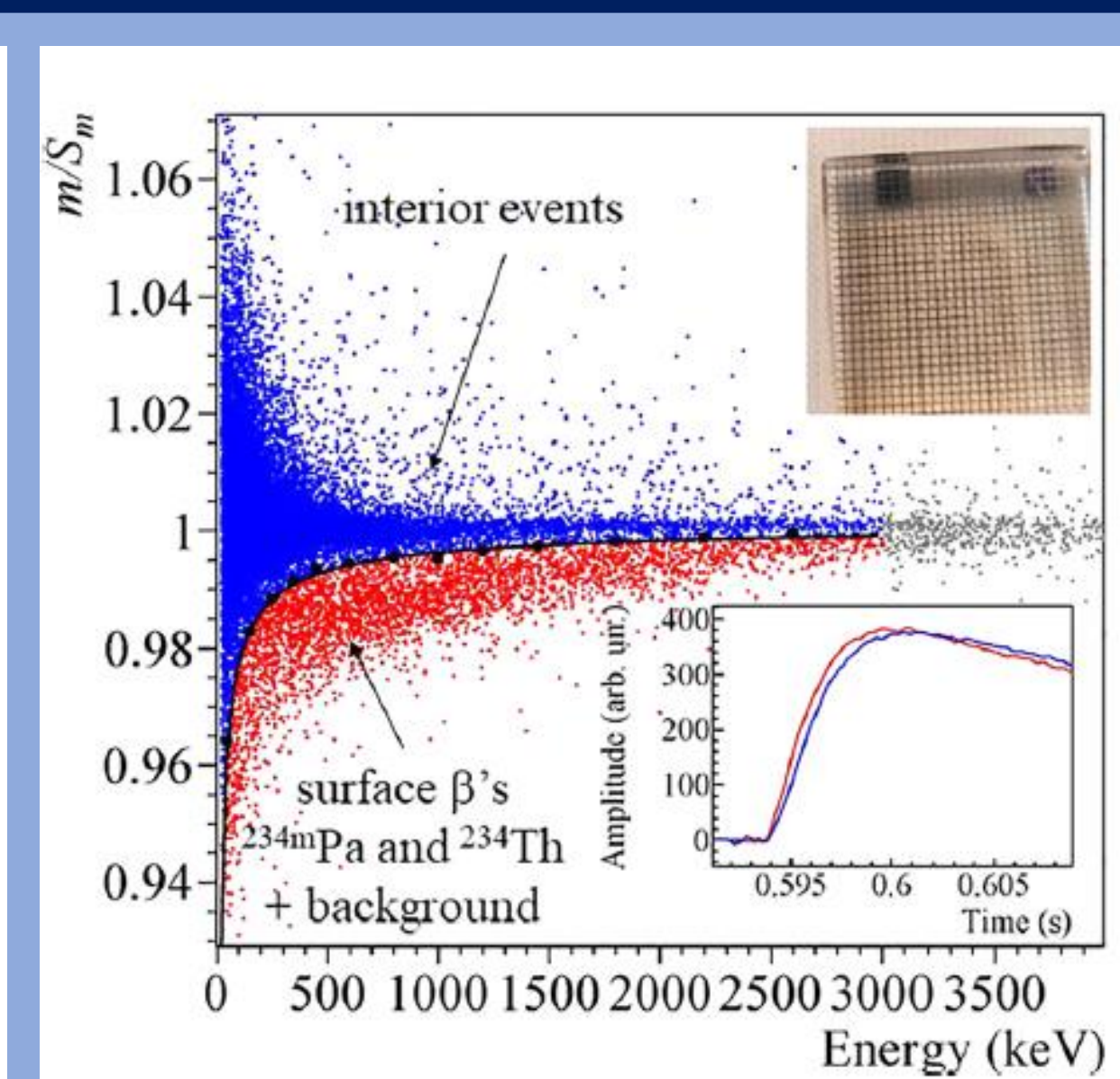
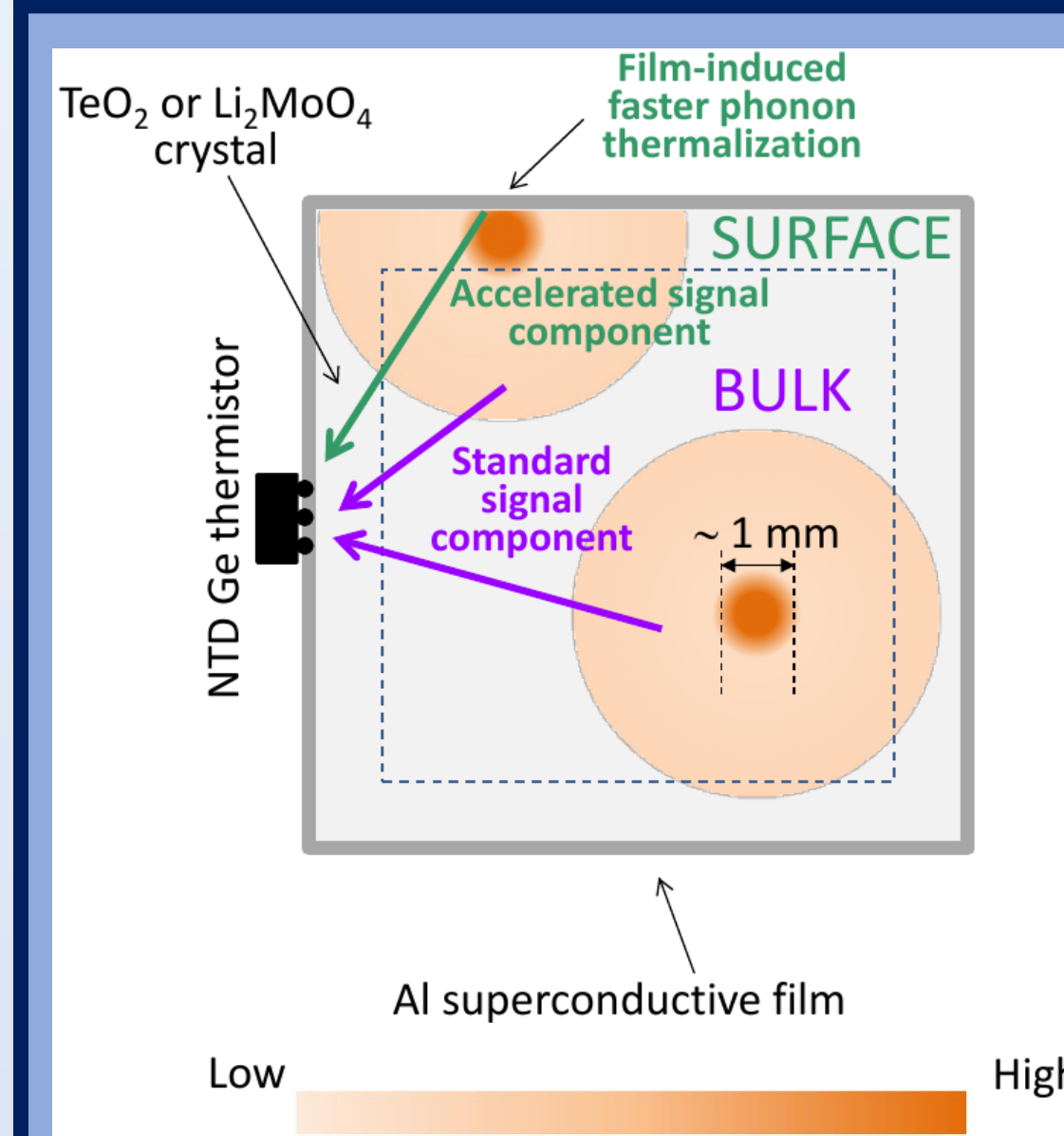
### Results:

- **$^{130}\text{TeO}_2$  crystal performance [9]:** confirmation of the radiopurity of the crystals ( $\sim 1 \text{ mBq/kg}$  activity of  $^{210}\text{Po}$ ) by bolometric measurements together with excellent energy resolution
- **NTL LD performance:**
  - **0V bias performance:** all LD have  $\sigma_{\text{baseline}} < 150 \text{ eV}$  which means 99.9%  $\alpha$  rejection factor (mean value of  $\sigma_{\text{baseline}} < 85 \text{ eV}$ )
  - **Leakage current:** all NTL LD were able to stand 50 V across the electrodes without developing leakage current and 8/9 were able to stand more than 90 V
  - **80V bias performance:**
    - mean value of  $\sigma_{\text{baseline}}$  is  $(12 \pm 4) \text{ eV}$  ( $G_{\text{NTL}} \sim 11$ ) and  $\text{SNR} = 89$ . Taking into account that only 56% of surface area is covered by the electrodes, we expect  $\sigma_{\text{baseline}} = 6.8 \text{ eV}$  and  $\text{SNR} = 152$  for the full surface coverage
    - working at  $\sim 1 \text{ MOhm}$  resistances of LD NTDs we reached rise-times 0.42–0.74 ms with a mean value  $(0.55 \pm 0.11) \text{ ms}$ . Together with achieved SNR, these results are important for pile-up rejection
    - higher gain is obtained when light impinges on the electrode side of the Ge wafer (factor 2.5 difference) [9] arXiv:2406.01444 (2024)



Background spectrum measured by a 0.55 kg  $^{130}\text{TeO}_2$  bolometer (116 h at 27 mK)

## 3. Evolution of the experiment



[2] JHEP 01 (2020) 018

[3] Appl. Phys. Lett. 118, 184105 (2021)

- **Discrimination between bulk / near surface  $\alpha$  and  $\beta$  interactions [3]:**
  - coatings with Al, Pd, and Al-Pd are studied
  - works for small samples, e.g.  $2 \times 2 \times 1 \text{ cm}^3$   $\text{Li}_2\text{MoO}_4$  crystal with Al-Pd grid
  - discrimination power of surface  $\alpha$ -s:  $\text{DP} \geq 4.5\sigma$
  - $\beta$  surface events selection efficiency (with Al-Pd):  $\sim 93\%$
  - baseline resolution is not affected and remains at keV level (with Al-Pd)
  - at the moment, there are difficulties in reproducing these results with larger samples
- **Light channel is exploited via Neganov-Trofimov-Luke light detectors (NTL-LDs)**
  - $\alpha$  discrimination due to lower light yield for alpha particles
  - to improve substantially pile-up (coincidence of two  $2\nu\beta\beta$  events) rejection

## 6. CUPID and CROSS interplay [7]

The CROSS cryogenic facility [8] is exploited to:

- **test performance of CUPID crystals**
  - crystals resolution and sensitivity
- **test NTL-LDs**
  - leakage current and sensitivity checks
  - search for optimal geometry of electrodes
  - studies on pile-ups rejection efficiency
- **probe assembly structures**

[7] JINST 18 (2023) P06018

[8] JINST 18 (2023) P12004

## 8. CROSS demonstrator

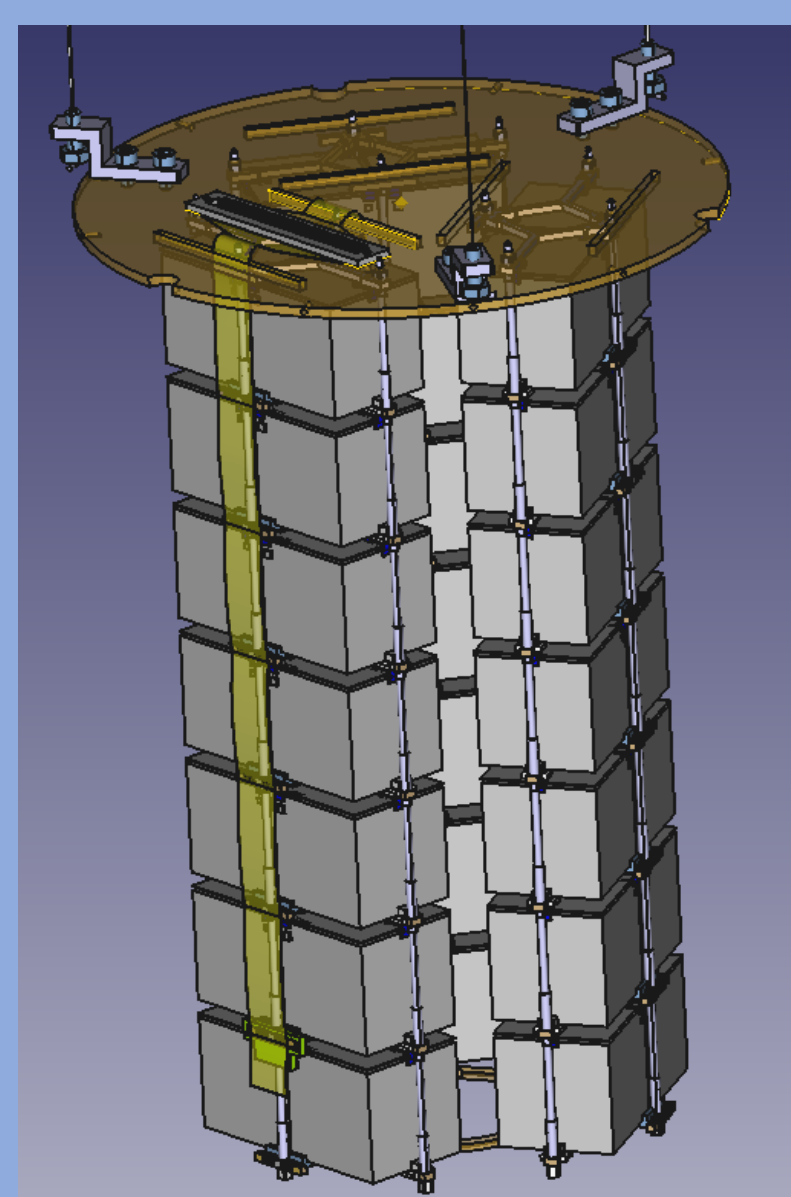
### Structure

- 3 towers with 7 floors each
- Each floor has 2 crystal + 2 NTL-LD
- Top floor consists of  $\text{TeO}_2$  crystals, that will work also as shielding to others crystals due to higher density

In total: 36  $\text{Li}_2^{100}\text{MoO}_4$  (32  $^{100}\text{Mo}$ -enriched) and 6  $\text{TeO}_2$  (all  $^{130}\text{Te}$ -enriched)

Total mass of  $^{100}\text{Mo}$ : 4.7 kg

Installation envisaged within the end of 2024  
Commissioning in early 2025



## 9. Sensitivity

According to current estimations (see poster N°343 by David Cintas) background index in the CROSS demonstrator can be estimated as:

- $10^{-2} \text{ counts/keV/kg/yr}$  in the worst case scenario
- $10^{-3} \text{ counts/keV/kg/yr}$  in the best case scenario

Assuming 2 years live time, the CROSS experiment will be able to set a limit (at 90% confidence level) on the  $^{100}\text{Mo}$   $0\nu\beta\beta$  decay:

- half-life  $T_{1/2}^{0\nu} > 8.5 \cdot 10^{24} \text{ yr}$  and  $\langle m_{\beta\beta} \rangle < (0.131-0.221) \text{ eV}$  in the worst case scenario
- half-life  $T_{1/2}^{0\nu} > 1.2 \cdot 10^{25} \text{ yr}$  and  $\langle m_{\beta\beta} \rangle < (0.110-0.186) \text{ eV}$  in the best case scenario

Even in the worst case scenario, the CROSS demonstrator will have higher sensitivity on the  $^{100}\text{Mo}$   $0\nu\beta\beta$  than the best current limits established by CUPID-Mo [10] and AMoRE-I [11] experiments.

[10] Eur.Phys.J.C 82 (2022) 11, 1033

[11] H.B. Kim. 2023. Result of AMoRE-I Experiment. TAUP, 30 August, Vienna